













AMC1336 SBAS951B - AUGUST 2019-REVISED APRIL 2020

AMC1336 Small, High-Precision, Reinforced Isolated Delta-Sigma Modulator for Voltage Sensing Applications

Features

Input structure optimized for voltage measurements:

Input voltage range: ±1 V Input resistance: 1.5 G Ω (typ)

Excellent DC performance:

Offset error: ±0.5 mV (max) Offset drift: ±4 µV/°C (max)

Gain error: ±0.25% (max)

Gain drift: ±40 ppm/°C (max)

Transient immunity: 115 kV/µs (typ)

Missing high-side supply detection Safety-related certifications:

8000-V_{PEAK} reinforced isolation per DIN VDE V 0884-11: 2017-01

5700-V_{RMS} isolation for 1 minute per UL1577

IEC 62368-1 end equipment standard

Applications

- Isolated AC and DC voltage measurement in:
 - Uninterruptible power supplies
 - Photovoltaic inverters
 - Motor drives

3 Description

The AMC1336 is a precision, delta-sigma ($\Delta\Sigma$) modulator with the output separated from the input circuitry by a capacitive double isolation barrier that is highly resistant to magnetic interference. This barrier is certified to provide reinforced isolation of up to 8000 V_{PEAK} according to the DIN VDE V 0884-11 and UL1577 standards. Used in conjunction with isolated power supplies, this isolated modulator separates parts of the system that operate on different commonmode voltage levels and protects lower-voltage parts from damage.

The unique wide, bipolar. ±1-V input voltage range of the AMC1336 and its high input resistance support direct connection of the device to resistive dividers in high-voltage applications. When used with a digital (for filter instance, as integrated TMS320F28004x, TMS320F2807x or TMS320F2837x microcontroller families) to decimate the output bitstream, the device can achieve 16 bits of resolution with a dynamic range of 87 dB at a data rate of 82 kSPS.

On the high-side, the AMC1336 is supplied by a 3.3-V or 5-V power supply. The isolated digital interface operates from a 3.0-V, 3.3-V or 5-V power supply.

The AMC1336 performance is specified over the extended industrial temperature range of -40°C to +125°C.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
AMC1336	SOIC (8)	5.85 mm × 7.50 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

Simplified Schematic

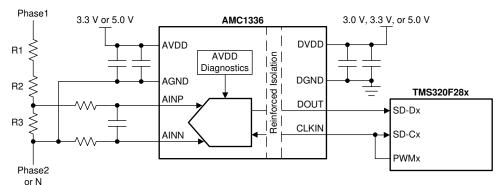




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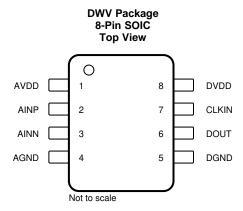
4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision A (December 2019) to Revision B	Page
• Changed P _D (AVDD = DVDD = 5.5 V) from 88 mW to 90.75 mW	
 Changed P_{D1} (AVDD = 5.5 V) from 55 mW to 57.75 mW 	5
Added UL certification file number	7
Changes from Original (August 2019) to Revision A	Page
Changed document status from advance information to production data	1



5 Pin Configuration and Functions



Pin Functions

-	NIK!		
F	PIN	1/0	
NO.	NAME		DESCRIPTION
1	AVDD	_	Analog (high-side) power supply, 3.0 V to 5.5 V. See the <i>Power Supply Recommendations</i> section for decoupling recommendations.
2	AINP	I	Noninverting analog input
3	AINN	I	Inverting analog input
4	AGND	_	Analog (high-side) ground reference
5	DGND	_	Digital (controller-side) ground reference
6	DOUT	0	Modulator bitstream output, updated with the rising edge of the clock signal present on CLKIN. Use the rising edge of the clock to latch the modulator bitstream at the input of the digital filter device.
7	CLKIN	1	Modulator clock input with internal pulldown resistor (typical value: 1 MΩ). The clock signal must be applied continuously for proper device operation; see the <i>Clock Input</i> section for additional details.
8	DVDD	_	Digital (controller-side) power supply, 2.7 V to 5.5 V. See the <i>Power Supply Recommendations</i> section for decoupling recommendations.



6 Specifications

6.1 Absolute Maximum Ratings

see(1)

		MIN	MAX	UNIT
Dower cumply voltage	AVDD to AGND	-0.3	6.5	V
Power-supply voltage	DVDD to DGND	-0.3	6.5	V
Analog input voltage	On the AINP and AINN pins	AGND – 5	AVDD + 0.5	٧
Digital input voltage	On the CLKIN pin	DGND - 0.5	DVDD + 0.5	V
Digital output voltage	On the DOUT pin	DGND - 0.5	DVDD + 0.5	٧
Input current	Continuous, any pin except power-supply pins	-10	10	mA
Temperature	Junction, T _J		150	°C
	Storage, T _{stg}	-65	150	٠.

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

			VALUE	UNIT
		Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±2000	
V _(ESD)	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 (2)	±1000	V

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating ambient temperature range (unless otherwise noted)

			MIN	NOM	MAX	UNIT
POWER	SUPPLY					
AVDD	High-side supply voltage	AVDD to AGND	3.0	5.0	5.5	V
DVDD	Controller-side	DVDD to DGND	2.7	3.3	5.5	V
ANALOG	INPUT		-1			
$V_{Clipping}$	Differential input voltage before clipping output	$V_{IN} = V_{AINP} - V_{AINN}$		±1.25		V
V _{FSR}	Specified linear differential full-scale voltage	$V_{IN} = V_{AINP} - V_{AINN}$	-1		1	V
	Absolute common-mode input voltage ⁽¹⁾	(V _{AINP} + V _{AINN}) / 2 to AGND	-2		AVDD	V
Vсм	Operating common-mode input voltage ⁽²⁾	$(V_{AINP} + V_{AINN}) / 2$ to AGND, 3.0 V \leq AVDD $<$ 4 V, $V_{AINP} = V_{AINN}$	-1.4	,	AVDD – 1.4	
		$(V_{AINP} + V_{AINN}) / 2$ to AGND, 3.0 V \(\text{AVDD} < 4.5 \text{ V}, \\ V_{AINP} - V_{AINN} = 1.25 \text{ V}	-0.8	,	AVDD – 2.4	V
		$(V_{AINP} + V_{AINN}) / 2$ to AGND, $4 \text{ V} \leq \text{AVDD} \leq 5.5 \text{ V},$ $V_{AINP} = V_{AINN}$	-1.4		2.7	V
		$(V_{AINP} + V_{AINN}) / 2$ to AGND, 4.5 V \le AVDD \le 5.5 V, $ V_{AINP} - V_{AINN} = 1.25$ V	-0.8		2.1	
DIGITAL	INPUT					
	Input voltage	V _{CLKIN} to DGND	DGND		DVDD	V
TEMPER	ATURE RANGE					
T _A	Operating ambient temperature		-40	25	125	°C

⁽¹⁾ Steady-state voltage supported by the device in case of a system failure. See specified common-mode input voltage V_{CM} for normal operation. Observe analog input voltage range as specified in the Absolute Maximum Ratings table.

(2) See the Analog Input section for more details.

⁽²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



6.4 Thermal Information

		AMC1336	
	THERMAL METRIC ⁽¹⁾	DWV (SOIC)	UNIT
		8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	94	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	36	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	46.1	°C/W
ΨЈТ	Junction-to-top characterization parameter	11.5	°C/W
ΨЈВ	Junction-to-board characterization parameter	44.4	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

6.5 Power Ratings

	PARAMETER	TEST CONDITIONS	VALUE	UNIT	
Б	Maximum navar dissination (bath sides)	AVDD = DVDD = 5.5 V	90.75	\A/	
P _D	Maximum power dissipation (both sides)	AVDD = DVDD = 3.6 V	50.4	mW	
D	Mayimum naugar discinction (high side cumple)	AVDD = 5.5 V	57.75	\A/	
P _{D1}	Maximum power dissipation (high-side supply)	AVDD = 3.6 V	32.4	mW	
D	Mayimum naugar discination (controller side cumply)	DVDD = 5.5 V	33	\/	
P _{D2}	Maximum power dissipation (controller-side supply)	DVDD = 3.6 V	18	mW	



6.6 Insulation Specifications

over operating ambient temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	VALUE	UNIT
GENERA	L			
CLR	External clearance ⁽¹⁾	Shortest pin-to-pin distance through air	≥ 8.5	mm
CPG	External creepage ⁽¹⁾	Shortest pin-to-pin distance across the package surface	≥ 8.5	mm
DTI	Distance through insulation	Minimum internal gap (internal clearance) of the double insulation	≥ 0.021	mm
СТІ	Comparative tracking index	DIN EN 60112 (VDE 0303-11); IEC 60112	≥ 600	V
	Material group	According to IEC 60664-1	ļ	
	Overvoltage category	Rated mains voltage ≤ 600 V _{RMS}	I-IV	
	per IEC 60664-1	Rated mains voltage ≤ 1000 V _{RMS}	I-III	
DIN VDE	V 0884-11: 2017-01 ⁽²⁾			
V_{IORM}	Maximum repetitive peak isolation voltage	At AC voltage	2121	V _{PK}
.,	Maximum-rated isolation	At AC voltage (sine wave); see Figure 5	1500	V _{RMS}
V_{IOWM}	working voltage	At DC voltage	2121	V _{DC}
V	Maximum transient	V _{TEST} = V _{IOTM} , t = 60 s (qualification test)	8000	V _{PK}
V_{IOTM}	isolation voltage	V _{TEST} = 1.2 × V _{IOTM} , t = 1 s (100% production test)	9600	
V_{IOSM}	Maximum surge isolation voltage (3)	Test method per IEC 60065, 1.2/50- μ s waveform, $V_{TEST} = 1.6 \times V_{IOSM} = 12800 V_{PK}$ (qualification)	8000	V _{PK}
	Apparent charge ⁽⁴⁾	Method a, after input/output safety test subgroups 2 & 3, $V_{ini} = V_{IOTM}$, $t_{ini} = 60$ s, $V_{pd(m)} = 1.2 \times V_{IORM}$, $t_{m} = 10$ s	≤ 5	pC
q _{pd}		Method a, after environmental tests subgroup 1, $V_{ini} = V_{IOTM}, \ t_{ini} = 60 \ s, \ V_{pd(m)} = 1.6 \times V_{IORM}, \ t_{m} = 10 \ s$	≤ 5	
		Method b1, at routine test (100% production) and preconditioning (type test), $V_{ini} = V_{IOTM}$, $t_{ini} = 1$ s, $V_{pd(m)} = 1.875 \times V_{IORM}$, $t_m = 1$ s	≤ 5	
C _{IO}	Barrier capacitance, input to output ⁽⁵⁾	V _{IO} = 0.5 V _{PP} at 1 MHz	~1	pF
		V _{IO} = 500 V at T _A = 25°C	> 10 ¹²	
R _{IO}	Insulation resistance, input to output (5)	V _{IO} = 500 V at 100°C ≤ T _A ≤ 125°C	> 10 ¹¹	Ω
	input to output	V _{IO} = 500 V at T _S = 150°C	> 10 ⁹	1
	Pollution degree		2	1
	Climatic category		55/125/21	
UL1577	1			
V _{ISO}	Withstand isolation voltage	$V_{TEST} = V_{ISO} = 5700 V_{RMS}$, $t = 60 s$ (qualification), $V_{TEST} = 1.2 \times V_{ISO} = 6840 V_{RMS}$, $t = 1 s$ (100% production test)	5700	V _{RMS}

⁽¹⁾ Apply creepage and clearance requirements according to the specific equipment isolation standards of an application. Care must be taken to maintain the creepage and clearance distance of a board design to ensure that the mounting pads of the isolator on the printed circuit board (PCB) do not reduce this distance. Creepage and clearance on a PCB become equal in certain cases. Techniques such as inserting grooves, ribs, or both on a PCB are used to help increase these specifications.

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⁽²⁾ This coupler is suitable for safe electrical insulation only within the safety ratings. Compliance with the safety ratings shall be ensured by means of suitable protective circuits.

⁽³⁾ Testing is carried out in air or oil to determine the intrinsic surge immunity of the isolation barrier.

⁽⁴⁾ Apparent charge is electrical discharge caused by a partial discharge (pd).

⁽⁵⁾ All pins on each side of the barrier are tied together, creating a two-pin device.



6.7 Safety-Related Certifications

VDE	UL
Certified according to DIN VDE V 0884-11: 2017-01, DIN EN 62368-1: 2016-05, EN 62368-1: 2014, and IEC 62368-1: 2014	Recognized under 1577 component recognition
Reinforced insulation	Single protection
Certificate number: 40040142	File number: E181974

6.8 Safety Limiting Values

Safety limiting intends to minimize potential damage to the isolation barrier upon failure of input or output circuitry.

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
, Safety input, output,		$R_{\theta JA} = 94^{\circ}\text{C/W}, T_J = 150^{\circ}\text{C}, T_A = 25^{\circ}\text{C},$ AVDD = DVDD = 5.5 V, see Figure 3			241	A
Is	or supply current	$R_{\theta,JA} = 94^{\circ}\text{C/W}, T_J = 150^{\circ}\text{C}, T_A = 25^{\circ}\text{C},$ AVDD = DVDD = 3.6 V, see Figure 3			369	mA
Ps	Safety input, output, or total power ⁽¹⁾	$R_{\theta JA} = 94^{\circ}C/W$, $T_J = 150^{\circ}C$, $T_A = 25^{\circ}C$, see Figure 4			1329	mW
T _S	Maximum safety temperature				150	°C

⁽¹⁾ The maximum safety temperature, T_S, has the same value as the maximum junction temperature, T_J, specified for the device. The I_S and P_S parameters represent the safety current and safety power, respectively. Do not exceed the maximum limits of I_S and P_S. These limits vary with the ambient temperature, T_A.

The junction-to-air thermal resistance, $R_{\theta,JA}$, in the *Thermal Information* table is that of a device installed on a high-K test board for leaded surface-mount packages. Use these equations to calculate the value for each parameter:

6.9 Electrical Characteristics

minimum and maximum specifications apply from $T_A = -40^{\circ}\text{C}$ to +125°C, AVDD = 3.0 V to 5.5 V, DVDD = 2.7 V to 5.5 V, AINP = -1 V to +1 V, and AINN = AGND = 0 V; typical specifications are at $T_A = 25^{\circ}\text{C}$, AVDD = 5 V, DVDD = 3.3 V, and $f_{\text{CLKIN}} = 20 \text{ MHz}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
ANALOG	INPUT					
R_{IN}	Single-ended input resistance	AINN = AGND	0.1	1.5		GΩ
R_{IND}	Differential input resistance		0.16	1.5		GΩ
C _{IN}	Single-ended input capacitance	AINN = AGND, f _{CLKIN} = 20 MHz		2		pF
C _{IND}	Differential input capacitance	f _{CLKIN} = 20 MHz		2		pF
I _{IB}	Input bias current	AINP = AINN = AGND; $I_{IB} = (I_{AINP} + I_{AINN}) / 2$	-10	±3	10	nA
TCI _{IB}	Input bias current drift	AINP = AINN = AGND; $I_{IB} = (I_{AINP} + I_{AINN}) / 2$		-14		pA/°C
I _{IO}	Input offset current	$I_{IO} = I_{AINP} - I_{AINN}$	-5	±1	5	nA
CMTI	Common-mode transient immunity	AGND – DGND = 1 kV	80	115		kV/μs

 $T_J = T_A + R_{\theta JA} \times P$, where P is the power dissipated in the device.

 $T_{J(max)} = T_S = T_A + R_{\theta JA} \times P_S$, where $T_{J(max)}$ is the maximum junction temperature.

 $P_S = I_S \times AVDD_{max} + I_S \times DVDD_{max}$, where $AVDD_{max}$ is the maximum high-side voltage and $DVDD_{max}$ is the maximum controller-side supply voltage.



Electrical Characteristics (continued)

minimum and maximum specifications apply from $T_A = -40$ °C to +125°C, AVDD = 3.0 V to 5.5 V, DVDD = 2.7 V to 5.5 V, AINP = -1 V to +1 V, and AINN = AGND = 0 V; typical specifications are at $T_A = 25$ °C, AVDD = 5 V, DVDD = 3.3 V, and f_{CLKIN} = 20 MHz (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
DC ACCUR	RACY						
	Resolution	Decimation filter output set to 16 bits	16			Bit	
INL	Integral nonlinearity ⁽¹⁾	Resolution: 16 bits	-4	±1.6	4	LSB	
Eo	Offset error	Initial, at T _A = 25°C, AINP = AINN = AGND	-0.5	±0.03	0.5	mV	
TCE _O	Offset error drift ⁽²⁾		-4	±0.6	4	μV/°C	
E _G	Gain error ⁽³⁾	Initial, at $T_A = 25^{\circ}C$, $V_{AINP} = 1 \text{ V or } V_{AINN} = -1 \text{ V, AINN} = \text{AGND}$	-0.25	±0.02	0.25	%	
TCE _G	Gain error drift ⁽⁴⁾		-40	±20	40	ppm/°C	
CMDD	0	AINP = AINN, f _{IN} = 0 Hz, V _{CM min} ≤ V _{CM} ≤ V _{CM max}		-104		٦D	
CMRR	Common-mode rejection ratio	AINP = AINN, $f_{IN} = 10 \text{ kHz}, -0.5 \text{ V} \le V_{IN} \le 0.5 \text{ V}$		-96		dB	
DODD	Davida and a significant and a	PSRR vs AVDD, at DC		-83		٦D	
PSRR	Power-supply rejection ratio	PSRR vs AVDD, 100-mV and 10-kHz ripple		-83		dB	
AC ACCU	RACY						
SNR	Signal-to-noise ratio	$V_{IN} = 2 V_{PP}, f_{IN} = 1 \text{ kHz}$	82	87		dB	
SINAD	Signal-to-noise + distortion	V _{IN} = 2 V _{PP} , f _{IN} = 1 kHz	79	85		dB	
THD	Total harmonic distortion	$V_{IN} = 2 V_{PP}, f_{IN} = 1 \text{ kHz}$		-91	-80	dB	
SFDR	Spurious-free dynamic range	V _{IN} = 2 V _{PP} , f _{IN} = 1 kHz	80	92		dB	
DIGITAL IN	NPUT (CMOS Logic With Schmitt-Trigge	r)			•		
I _{IN}	Input current	DGND ≤ V _{IN} ≤ DVDD			7	μA	
C _{IN}	Input capacitance			4		pF	
V _{IH}	High-level input voltage		0.7 x DVDD		DVDD + 0.3	V	
V _{IL}	Low-level input voltage		-0.3		0.3 x DVDD	V	
DIGITAL O	OUTPUT (CMOS)						
C _{LOAD}	Output load capacitance	f _{CLKIN} = 21 MHz		15	30	pF	
.,		I _{OH} = -20 μA	DVDD - 0.1			.,	
V _{OH}	High-level output voltage	$I_{OH} = -4 \text{ mA}$	DVDD - 0.4			V	
	I I I I I I I I	I _{OL} = 20 μA			0.1	W	
V _{OL}	Low-level output voltage	I _{OL} = 4 mA	0.4		0.4	V	
POWER SI	UPPLY						
AVDD _{POR}	AVDD power-on reset threshold voltage	AVDD falling	2.4	2.6	2.8	V	
	Lligh side supply suggest	3 V ≤ AVDD ≤ 3.6 V		6.8	9	A	
I _{AVDD}	High-side supply current	4.5 V ≤ AVDD ≤ 5.5 V		7.8	10.5	mA	
	Controller side oursely ourselt	2.7 V ≤ DVDD ≤ 3.6 V, C _{LOAD} = 15 pF		3.4	5	A	
I _{DVDD}	Controller-side supply current	$4.5 \text{ V} \le \text{DVDD} \le 5.5 \text{ V}, \text{ C}_{\text{LOAD}} = 15 \text{ pF}$ 3.7				6 mA	

⁽¹⁾ Integral nonlinearity is defined as the maximum deviation from a straight line passing through the end-points of the ideal ADC transfer function expressed as number of LSBs or as a percent of the specified linear full-scale range FSR.

Offset error drift is calculated using the box method, as described by the following equation:

TCE_O = (value_{MAX} - value_{MIN}) / TempRange
The typical value includes one sigma statistical variation.
Gain error drift is calculated using the box method, as described by the following equation: TCE_G (ppm) = ((value_{MAX} - value_{MIN}) / (value x TempRange)) X 10⁶



6.10 Switching Characteristics

over operating ambient temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
	CLIZINI ala di faranzia an	3.0 V ≤ AVDD ≤ 5.5 V	9	20	21	NAL 1-
f _{CLKIN}	CLKIN clock frequency	4.5 V ≤ AVDD ≤ 5.5 V	5	20	21	MHz
	CLKIN duty cycle		40%	50%	60%	
t _{H1}	DOUT hold time after rising edge of CLKIN	$C_{LOAD} = 15 pF$	3.5			ns
t _{D1}	Rising edge of CLKIN to DOUT valid delay	C _{LOAD} = 15 pF			15	ns
	BOLIT : "	10% to 90%, 2.7 V \leq DVDD \leq 3.6 V _, C _{LOAD} = 15 pF		2.5	6	ns
l _r	DOUT rise time	10% to 90%, 4.5 V \leq DVDD \leq 5.5 V, C_{LOAD} = 15 pF		3.2	6	ns
	DOUT fall time	10% to 90%, 2.7 V \leq DVDD \leq 3.6 V _, C _{LOAD} = 15 pF		2.2	6	ns
L _f	DOOT fall tiffle	10% to 90%, 4.5 V \leq DVDD \leq 5.5 V, C _{LOAD} = 15 pF		2.9	6	ns
t _{ASTART}	Analog start-up time	AVDD step to 3.0 V; 0.1%-settling, clock applied		0.25		ms

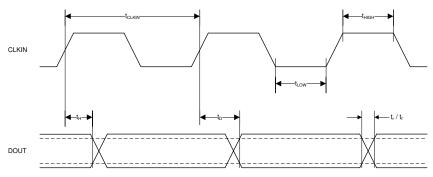


Figure 1. Digital Interface Timing

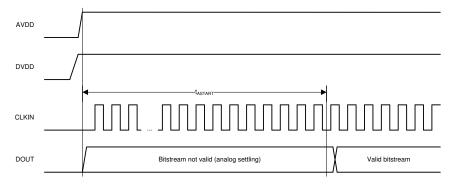
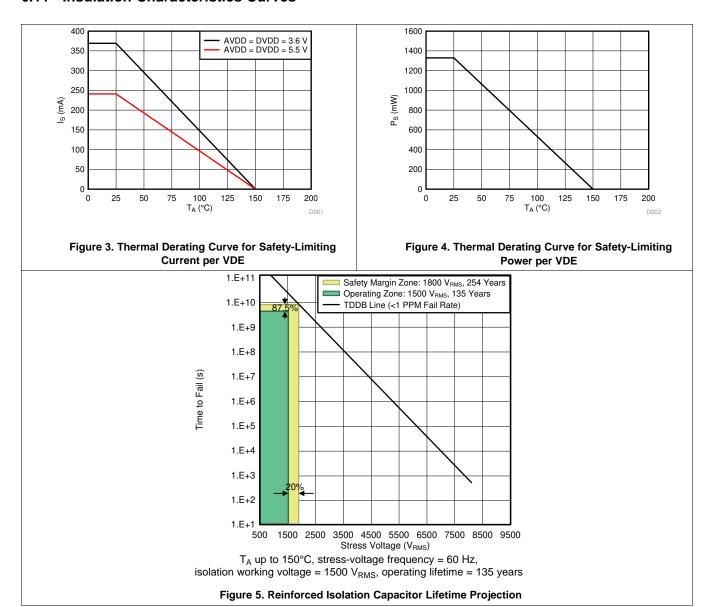


Figure 2. Device Start-Up Timing



6.11 Insulation Characteristics Curves

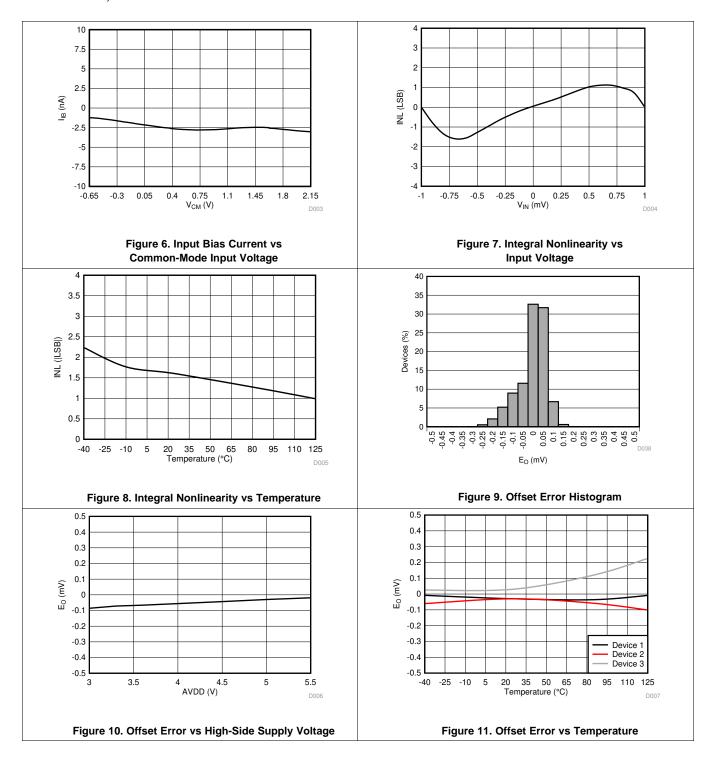


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6.12 Typical Characteristics

at AVDD = 5 V, DVDD = 3.3 V, AINP = -1 V to 1 V, AINN = AGND, f_{CLKIN} = 20 MHz, and sinc³ filter with OSR = 256 (unless otherwise noted)

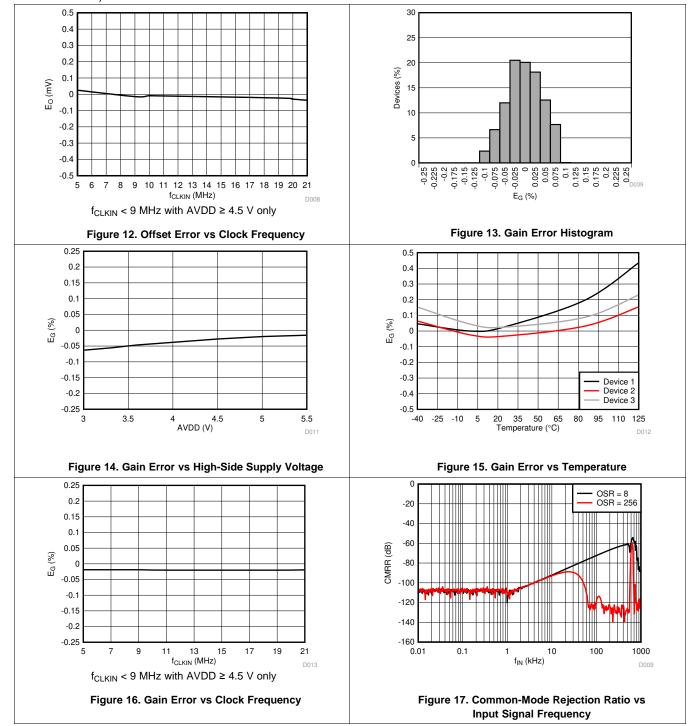


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at AVDD = 5 V, DVDD = 3.3 V, AINP = -1 V to 1 V, AINN = AGND, $f_{CLKIN} = 20$ MHz, and $sinc^3$ filter with OSR = 256 (unless otherwise noted)

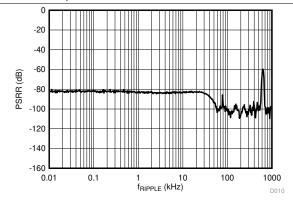


Figure 18. Power-Supply Rejection Ratio vs Ripple Frequency

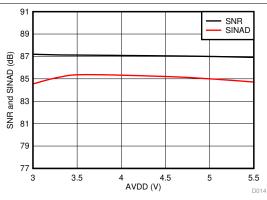


Figure 19. Signal-to-Noise Ratio and Signal-to-Noise +
Distortion vs High-Side Supply Voltage

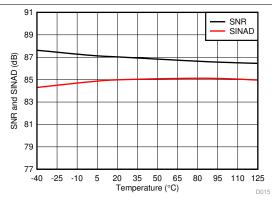


Figure 20. Signal-to-Noise Ratio and Signal-to-Noise + Distortion vs Temperature

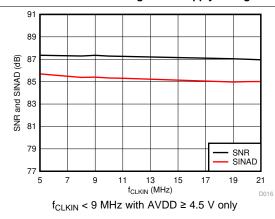


Figure 21. Signal-to-Noise Ratio and Signal-to-Noise + Distortion vs Clock Frequency

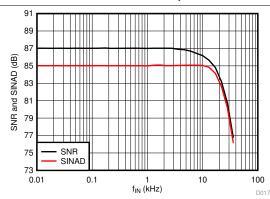


Figure 22. Signal-to-Noise Ratio and Signal-to-Noise + Distortion vs Input Signal Frequency

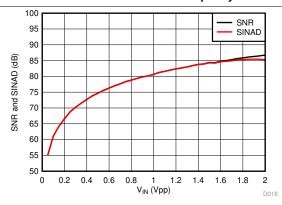


Figure 23. Signal-to-Noise Ratio and Signal-to-Noise + Distortion vs Input Signal Amplitude

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at AVDD = 5 V, DVDD = 3.3 V, AINP = -1 V to 1 V, AINN = AGND, $f_{CLKIN} = 20$ MHz, and $sinc^3$ filter with OSR = 256 (unless otherwise noted)

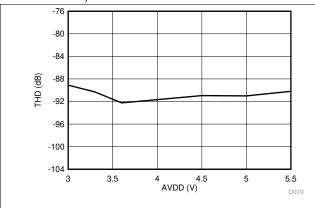


Figure 24. Total Harmonic Distortion vs High-Side Supply Voltage

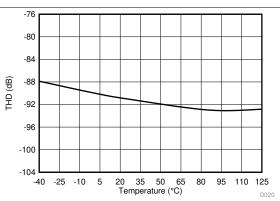


Figure 25. Total Harmonic Distortion vs Temperature

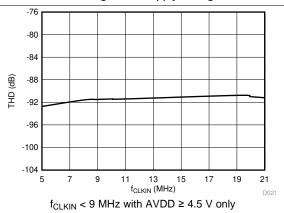


Figure 26. Total Harmonic Distortion vs Clock Frequency

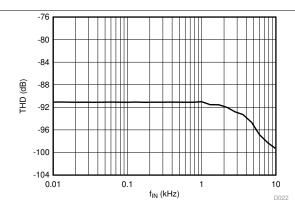


Figure 27. Total Harmonic Distortion vs Input Signal Frequency

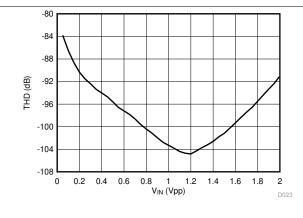


Figure 28. Total Harmonic Distortion vs Input Signal Amplitude

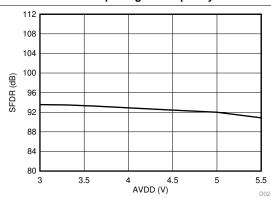


Figure 29. Spurious-Free Dynamic Range vs High-Side Supply Voltage

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at AVDD = 5 V, DVDD = 3.3 V, AINP = -1 V to 1 V, AINN = AGND, $f_{CLKIN} = 20$ MHz, and $sinc^3$ filter with OSR = 256 (unless otherwise noted)

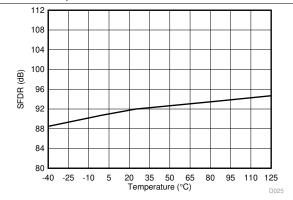


Figure 30. Spurious-Free Dynamic Range vs Temperature

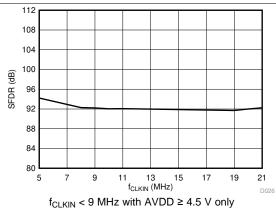


Figure 31. Spurious-Free Dynamic Range vs Clock Frequency

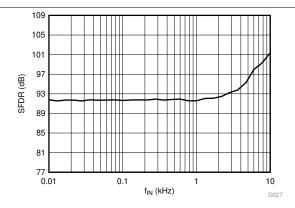


Figure 32. Spurious-Free Dynamic Range vs Input Signal Frequency

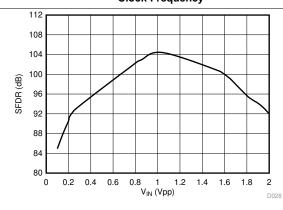
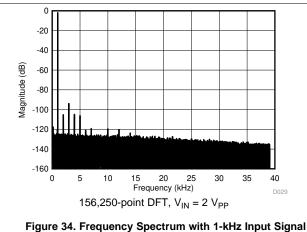


Figure 33. Spurious-Free Dynamic Range vs Input Signal Amplitude



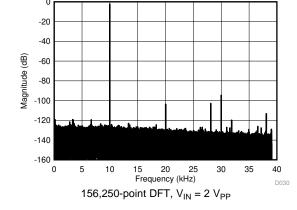


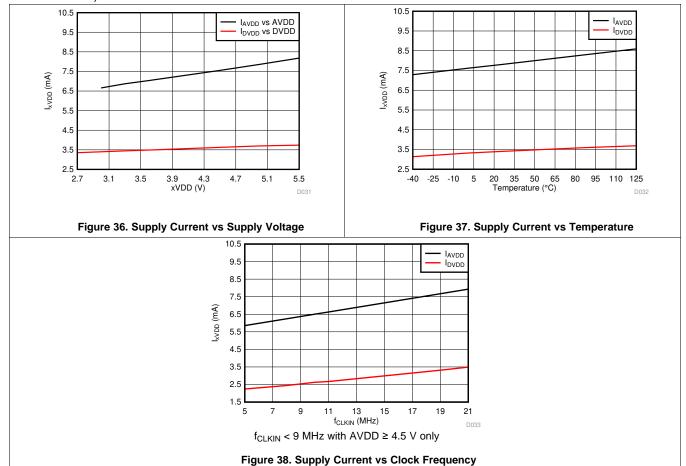
Figure 35. Frequency Spectrum with 10-kHz Input Signal

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at AVDD = 5 V, DVDD = 3.3 V, AINP = -1 V to 1 V, AINN = AGND, $f_{CLKIN} = 20$ MHz, and sinc³ filter with OSR = 256 (unless otherwise noted)



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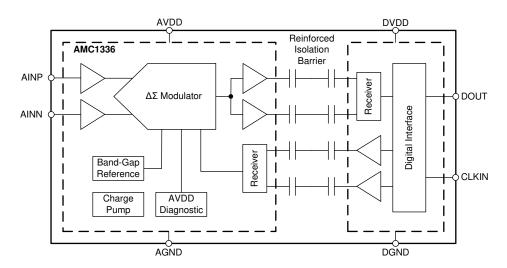
7 Detailed Description

7.1 Overview

The differential analog input (comprised of input signals AINP and AINN) of the AMC1336 is a chopper-stabilized instrumentation amplifier, followed by the switched-capacitor input of a second-order, delta-sigma ($\Delta\Sigma$) modulator stage that digitizes the input signal into a 1-bit output stream. The data output DOUT of the converter provides a stream of digital ones and zeros that is synchronous to the externally provided clock source at the CLKIN pin with a frequency in the range of 5 MHz to 21 MHz. The time average of this serial bitstream output is proportional to the analog input voltage. The *Functional Block Diagram* section shows a detailed block diagram of the AMC1336. The 1.6-G Ω differential input resistance of the analog input stage supports low gain-error signal sensing in high-voltage applications using resistive dividers. The external clock input simplifies the synchronization of multiple current-sensing channels on the system level.

The silicon-dioxide (SiO₂)-based capacitive isolation barrier supports a high level of magnetic field immunity, as described in the *ISO72x Digital Isolator Magnetic-Field Immunity* application report, available for download at www.ti.com.

7.2 Functional Block Diagram



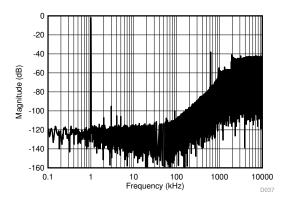
7.3 Feature Description

7.3.1 Analog Input

The AMC1336 incorporates front-end circuitry that contains an instrumentation amplifier, followed by a $\Delta\Sigma$ modulator. To support a bipolar input range with a unipolar high-side supply AVDD, the device uses a charge pump to simplify the overall system design and minimize circuit cost. For reduced offset and offset drift, the input buffer is chopper-stabilized with the switching frequency set at f_{CLKIN} / 32. Figure 39 illustrates the spur created by the switching frequency.

TEXAS INSTRUMENTS

Feature Description (continued)



 $sinc^3$ filter, OSR = 1, f_{CLKIN} = 20 MHz, f_{IN} = 1 kHz

Figure 39. Quantization Noise Shaping

The linearity and noise performance of the device are ensured only when the differential analog input voltage remains within the specified linear full-scale range (FSR), that is ±1 V, and within the specified input common-mode range.

Figure 40 shows the specified common-mode input voltage that applies for the full-scale input voltage range as specified in this document.

If smaller input signals are used, the operational common-mode input voltage range widens. Figure 41 shows the common-mode input voltage that applies with no differential input signal; that is, when the voltage applied on AINP is equal to the voltage applied on AINN. The common-mode input voltage range scales with the actual differential input voltage between this range and the range in Figure 40.

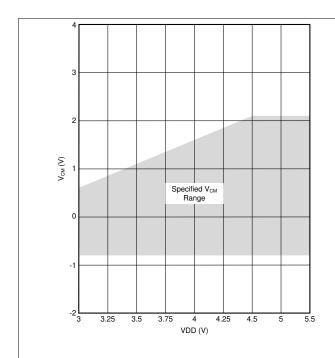


Figure 40. Common-Mode Input Voltage Range With a Clipping Differential Input Signal of ±1.25 V

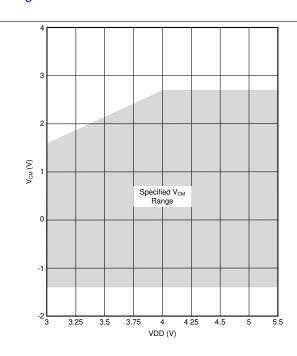


Figure 41. Common-Mode Input Voltage Range With a Zero Differential Input Signal

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There are two restrictions on the analog input signals (AINP and AINN). First, if the input voltage exceeds the range AGND - 5 V to AVDD + 0.5 V, the input current must be limited to 10 mA because the device input electrostatic discharge (ESD) diodes turn on. In addition, the linearity and noise performance of the device are ensured only when the differential analog input voltage remains within the specified linear full-scale range (FSR) and within the specified input common-mode range.

7.3.2 Modulator

The modulator implemented in the AMC1336, as conceptualized in Figure 42, is a second-order, switched-capacitor, feed-forward $\Delta\Sigma$ modulator. The analog input voltage V_{IN} and the output V_5 of the 1-bit digital-to-analog converter (DAC) are subtracted, providing an analog voltage V_1 at the input of the first integrator stage. The output of the first integrator feeds the input of the second integrator stage, resulting in an output voltage V_3 that is differentiated with the input signal V_{IN} and the output of the first integrator V_2 . Depending on the polarity of the resulting voltage V_4 , the output of the comparator is changed. In this case, the 1-bit DAC responds on the next clock pulse by changing the associated analog output voltage V_5 , causing the integrators to progress in the opposite direction and forcing the value of the integrator output to track the average value of the input.

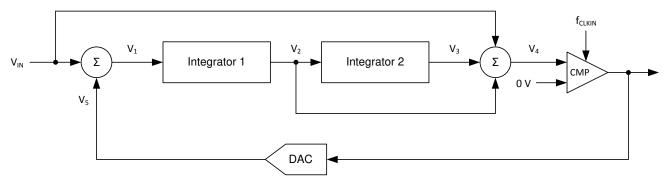


Figure 42. Block Diagram of a Second-Order Modulator

As depicted in Figure 39, the modulator shifts the quantization noise to high frequencies. Therefore, use a low-pass digital filter at the output of the device to increase the overall performance. This filter is also used to convert from the 1-bit data stream at a high sampling rate into a higher-bit data word at a lower rate (decimation). Tl's microcontroller families TMS320F2807x and TMS320F2837x offer a suitable programmable, hardwired filter structure termed a sigma-delta filter module (SDFM) optimized for usage with the AMC1336. Furthermore, the SD24_B converters on the MSP430F677x microcontrollers offer a path to directly access the integrated sinc filters for a simple system-level solution for multichannel, isolated current sensing. An additional option is to use a suitable application-specific device, such as the AMC1210 (a four-channel digital sinc-filter). Alternatively, a field-programmable gate array (FPGA) can be used to implement the filter.



7.3.3 Isolation Channel Signal Transmission

The AMC1336 uses an on-off keying (OOK) modulation scheme to transmit the modulator output bitstream across the capacitive SiO₂-based isolation barrier. The transmitter modulates the bitstream at TX IN in Figure 43 with an internally-generated, 480-MHz carrier across the isolation barrier to represent a digital *one* and sends a *no signal* to represent the digital *zero*. The receiver demodulates the signal after advanced signal conditioning and produces the output. The symmetrical design of each isolation channel improves the common-mode transient immunity (CMTI) performance and reduces the radiated emissions caused by the high-frequency carrier. Figure 43 shows the block diagram of an isolation channel integrated in the AMC1336.

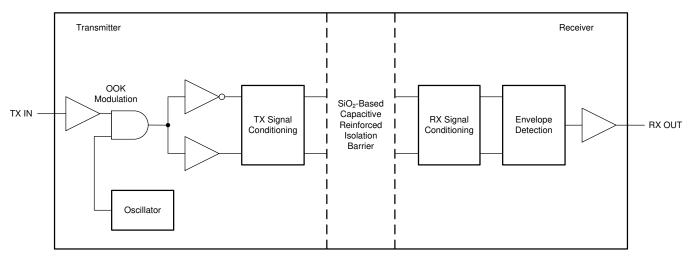


Figure 43. Block Diagram of an Isolation Channel

Figure 44 shows the concept of the on-off keying scheme.

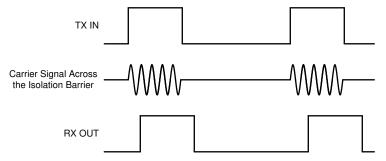


Figure 44. OOK-Based Modulation Scheme



7.3.4 Clock Input

The AMC1336 system clock is provided externally at the CLKIN pin. The clock signal must be applied continuously for proper device operation.

To support the bipolar input voltage range with a unipolar high-side supply AVDD, the AMC1336 includes a charge pump. This charge pump stops operating if the clock signal is below the specified frequency range or if the signal is paused or missing. In that case, the input bias current increases beyond the specified range and significantly reduces the input resistance of the device. When the clock signal is paused or missing, the modulator stops the analog signal conversion and the digital output signal remains frozen in the last logic state. When the clock signal is applied again after a pause, the internal analog circuitry biasing must settle for proper device performance. In this case, consider the t_{ASTART} specification in the *Switching Characteristics* table.

7.3.5 Digital Output

A differential input signal of 0 V ideally produces a stream of ones and zeros that are high 50% of the time. A differential input of 1 V produces a stream of ones and zeros that are high 90% of the time. With 16 bits of resolution, that percentage ideally corresponds to code 58982 (an unsigned code). A differential input of -1 V produces a stream of ones and zeros that are high 10% of the time and ideally results in code 6553 with 16-bit resolution. These input voltages are also the specified linear range of the AMC1336 with performance as specified in this document. If the input voltage value exceeds this range, the output of the modulator shows nonlinear behavior when the quantization noise increases. The output of the modulator clips with a stream of only zeros with an input less than or equal to -1.25 V or with a stream of only ones with an input greater than or equal to 1.25 V. In this case, however, the AMC1336 generates a single 1 (if the input is at negative full-scale) or 0 every 128 clock cycles to indicate proper device function (see the AVDD Diagnostics and Fail-Safe Output section for more details). Figure 45 shows the input voltage versus the output modulator signal.

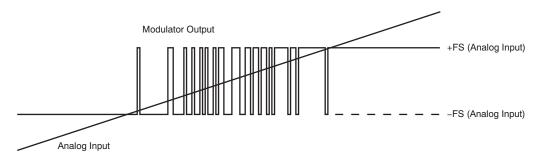


Figure 45. Analog Input versus the AMC1336 Modulator Output

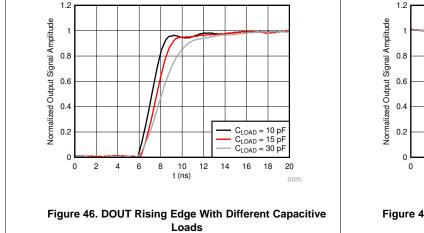
Equation 1 calculates the density of ones in the output bitstream for any input voltage value (with the exception of a full-scale input signal, as described in the *Output Behavior in Case of a Full-Scale Input* section):

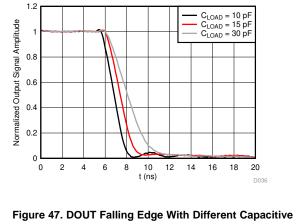
$$\frac{V_{IN} + V_{Clipping}}{2 \times V_{Clipping}}$$
 (1)

The modulator bitstream on the DOUT pin changes with the rising edge of the clock signal applied on the CLKIN pin. Use the rising edge of the clock to latch the modulator bitstream at the input of the digital filter device.



The AMC1336 features a slew-rate-controlled output stage that reduces the over- and undershoots of the output amplitude and radiated emissions of the DOUT line in the system. Figure 46 and Figure 47 show examples of rising and falling edges of DOUT with different capacitive loads.





Loads

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7.4 Device Functional Modes

The AMC1336 is operational when the power supplies AVDD and DVDD, and the clock signal CLKIN are applied, as specified in the *Recommended Operating Conditions* and *Switching Characteristics* tables.

7.4.1 Output Behavior in Case of a Full-Scale Input

Figure 48 shows that if a full-scale input signal is applied to the AMC1336 (that is, $V_{IN} \ge V_{Clipping}$), the device generates a single one or zero every 128 bits at DOUT, depending on the actual polarity of the signal being sensed. This feature can be used for advanced system-level diagnostics to differentiate between system failures caused by missing high-side supply AVDD or input overvoltage events.

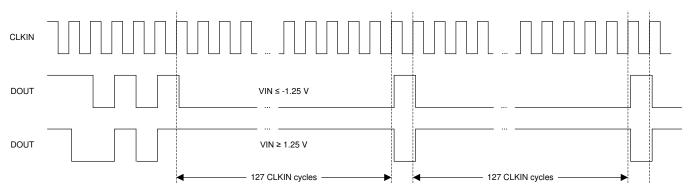


Figure 48. Out-of-Range Output of the AMC1336

7.4.2 AVDD Diagnostics and Fail-Safe Output

In the case of a missing high-side supply voltage AVDD, the output of a $\Delta\Sigma$ modulator is not defined and can cause a system malfunction. In systems with high safety requirements, this behavior is not acceptable. As shown in Figure 49, the AMC1336 implements an AVDD diagnostics and fail-safe output function that ensures that the output DOUT of the device offers a steady-state bitstream of logic 0's in case of a missing AVDD. Sample at least 128 CLKIN cycles in order to distinguish a missing AVDD condition from an input underrange condition.

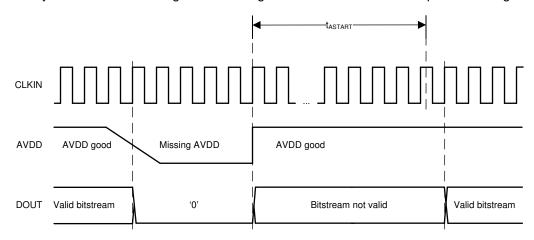


Figure 49. Fail-Safe Output of the AMC1336



8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

8.1.1 Digital Filter Usage

The modulator generates a bitstream that is processed by a digital filter to obtain a digital word similar to a conversion result of a conventional analog-to-digital converter (ADC). Equation 2 shows a sinc³-type filter, which is a very simple filter that is built with minimal effort and hardware:

$$H(z) = \left(\frac{1 - z^{-OSR}}{1 - z^{-1}}\right)^{3}$$
 (2)

This filter provides the best output performance at the lowest hardware size (count of digital gates) for a second-order modulator. All the characterization in this document is also done with a sinc³ filter with an oversampling ratio (OSR) of 256 and an output word width of 16 bits.

An example code for implementing a sinc³ filter in an FPGA is discussed in the *Combining the ADS1202 with an FPGA Digital Filter for Current Measurement in Motor Control Applications* application note, available for download at www.ti.com.



8.2 Typical Application

Isolated $\Delta\Sigma$ modulators are widely used in frequency inverter designs because of their high AC and DC performance. Frequency inverters are critical parts of industrial motor drives, photovoltaic inverters (string and central inverters), uninterruptible power supplies (UPS), and other industrial applications.

Figure 50 shows a simplified schematic of a frequency inverter application with the AMC1336 used for the DC-link and output phase voltage sensing. In this example, the ground reference point for the microcontroller is not connected by any means to the power stage. This configuration is usually the case in systems with the microcontroller located on a dedicated control card or PCB.

Current feedback is performed with shunt resistors (R_{SHUNT}) and TI's AMC1306M25 isolated modulators. Depending on the system design, either all three or only two motor phase currents are sensed.

Depending on the overall digital processing power requirements and with a total of eight $\Delta\Sigma$ modulator bitstreams to be processed by the microcontroller (MCU), a derivate from either the low-cost single-core TMS320F2807x or the dual-core TMS320F2837x families can be used in this application.

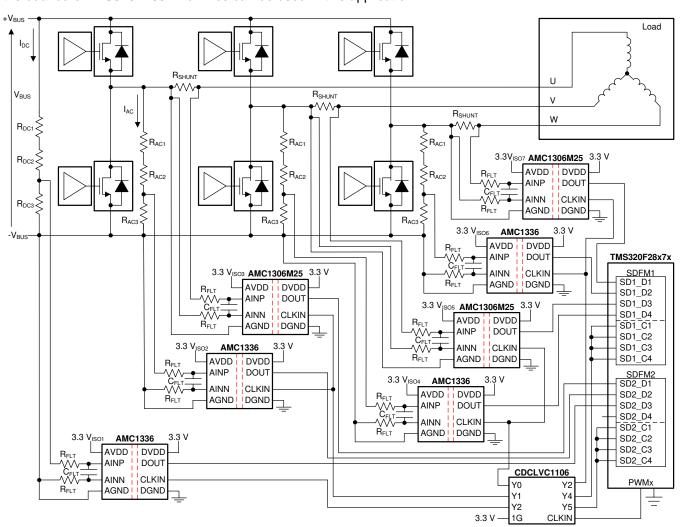


Figure 50. The AMC1336 in a Frequency Inverter Application

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Typical Application (continued)

Figure 51 shows an additional example of the AMC1336 used for input phase and DC-link voltage sensing. Also in this case, the microcontroller is located on a dedicated control card and the AMC1306M25 is used for shunt-based current sensing.

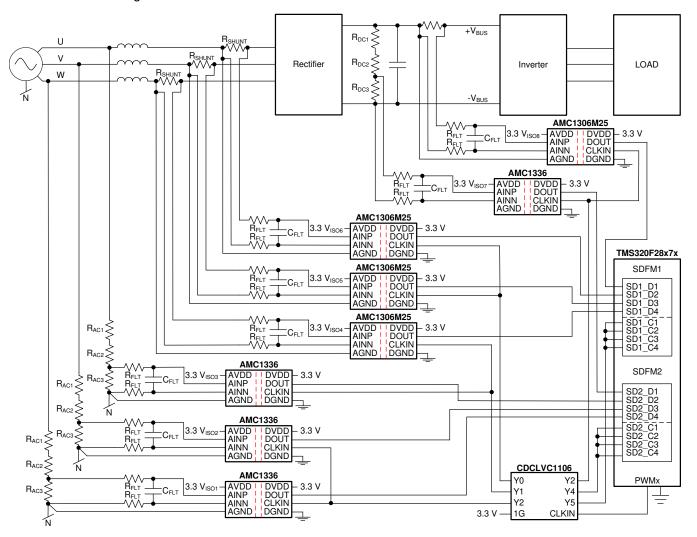


Figure 51. Input Phase Voltage Sensing Application with AMC1336

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Typical Application (continued)

8.2.1 Design Requirements

Table 1 lists the parameters for this typical application.

Table 1. Design Requirements

PARAMETER	VALUE		
Supply voltage	3.3 V		
Voltage drop across the sensing resistor R _{DC1} for a linear response	1 V (maximum)		
Voltage drop across the sensing resistors R _{ACx} for a linear response	±1 V (maximum)		
Current through the sensing resistors R _{ACx}	±100 μA (maximum)		

8.2.2 Detailed Design Procedure

Use Ohm's Law to calculate the minimum total resistance of the resistive dividers to limit the cross current to the desired values:

- For the voltage sensing on the DC bus: $R_{DC1} + R_{DC2} + R_{DC3} = V_{BUS} / I_{DC}$
- For the voltage sensing on the output phases U, V, and W: R_{AC1} + R_{AC2} + R_{AC3} = V_{PHASE (max)} / I_{AC}

Consider the following two restrictions to choose the proper value of the resistors R_{DC3} and R_{AC3}:

- The voltage drop caused by the nominal voltage range of the system must not exceed the recommended input voltage range of the AMC1336: V_{xC3} ≤ V_{FSR}
- The voltage drop caused by the maximum allowed system overvoltage must not exceed the input voltage that
 causes a clipping output: V_{xC3} ≤ V_{Clipping}

Use similar approach for calculation of the shunt resistor values R_{SHUNT} and see the AMC1306M25 data sheet for further details.

Table 2 lists examples of nominal E96-series (1% accuracy) resistor values for systems using 600 V and 800 V on the DC bus.

Table 2. Resistor Value Examples for DC Bus Sensing

PARAMETER	600-V DC BUS	800-V DC BUS
Resistive divider resistor R _{DC1}	3.01 MΩ	4.22 MΩ
Resistive divider resistor R _{DC2}	3.01 MΩ	4.22 MΩ
Sense resistor R _{DC3}	10 kΩ	10.5 kΩ
Resulting current through resistive divider I _{DC}	99.5 μΑ	94.7 μΑ
Resulting voltage drop on sense resistor V _{RDC3}	0.995 V	0.994 V

Table 3 lists examples of nominal E96-series (1% accuracy) resistor values for systems using 230 V and 690 V on the input or output phases.

Table 3. Resistor Value Examples for Phase Voltage Sensing

PARAMETER	±400-V _{AC} PHASE	±690-V _{AC} PHASE
Resistive divider resistor R _{AC1}	2.0 ΜΩ	3.48 MΩ
Resistive divider resistor R _{AC2}	2.0 ΜΩ	3.48 MΩ
Sense resistor R _{AC3}	10.0 kΩ	10.0 kΩ
Resulting current through resistive divider I _{AC}	99.8 μΑ	99.0 μΑ
Resulting voltage drop on sense resistor V _{RAC3}	±0.998 V	±0.990 V



Use a power supply with a nominal voltage of 3.3 V for DVDD to directly connect all modulators to the microcontroller.

For modulator output bitstream filtering, a device from Tl's TMS320F2807x family of low-cost microcontrollers (MCUs) or TMS320F2837x family of dual-core MCUs is recommended. These MCU families support up to eight channels of dedicated hardwired filter structures called sigma-delta filter modules (SDFMs) that significantly simplify system level design by offering two filtering paths per channel: one providing high accuracy results for the control loop and one that offers a fast response path for overcurrent detection. Use one of the pulse-width modulation (PWM) sources inside the MCU to generate the clock for the modulators and for easy synchronization of all feedback signals and the switching control of the gate drivers.

The application examples in Figure 50 and Figure 51 use a clock buffer to distribute the clock reference signal generated on one of the PWMx outputs of the MCU to all modulators used in the circuit and as a reference for the digital filters in the MCU. In this example, TI's CDCLVC1106 is used for this purpose. Each CDCLVC1106 output can drive a load of 8 pF that is sufficient to drive up to two modulator and up to four SDFM clock inputs.

8.2.3 Application Curve

The effective number of bits (ENOB) is often used to compare the performance of ADCs and $\Delta\Sigma$ modulators. Figure 52 shows the ENOB of the AMC1336 with different oversampling ratios. In this document, this number is calculated from the SINAD by using following equation: SINAD = 1.76 dB + 6.02 x ENOB.

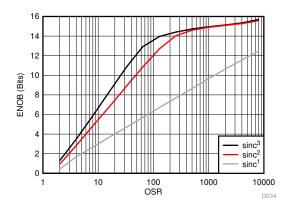


Figure 52. Measured Effective Number of Bits versus Oversampling Ratio

8.2.4 What to Do and What Not to Do

Do not leave the inputs of the AMC1336 unconnected (floating) when the device is powered up. If either modulator input is left floating, the input bias current can drive this input beyond the specified common-mode input voltage range. If both inputs are beyond that range, the gain of the front-end diminishes and the output bitstream is not valid.



9 Power Supply Recommendations

In a typical frequency-inverter application, the high-side power supply (AVDD) for the AMC1336 is generated from the controller-side supply (DVDD) of the device by an isolated dc/dc converter circuit. Figure 53 shows a low-cost solution based on the push-pull driver SN6501 and a transformer that supports the desired isolation voltage ratings. TI recommends using a low-ESR decoupling capacitor of 0.1 μ F and an additional capacitor of minimum 1 μ F for both supplies of the AMC1336. Place these decoupling capacitors as close as possible to the device power-supply pins to minimize supply current loops and electromagnetic emissions.

The AMC1336 does not require any specific power up sequencing. Consider the analog settling time t_{ASTART} as specified in the *Switching Characteristics* table after ramp up of the AVDD high-side supply.

Connect the high-side ground pin AGND of the AMC1336 to one of the analog inputs AINx to avoid common-mode input voltage range violations.

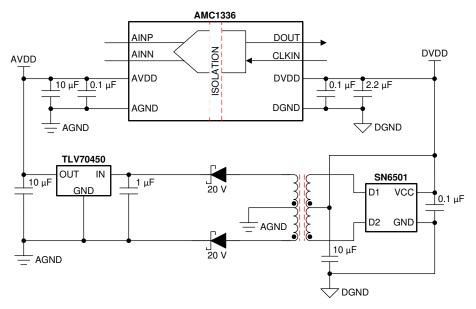


Figure 53. Decoupling the AMC1336



10 Layout

10.1 Layout Guidelines

Figure 54 shows an example layout that is used on the AMC1336 evaluation module. For best performance, place the smaller 0.1-μF decoupling capacitors (C7 and C9) as close as possible to the AMC1336 power-supply pins, followed by the additional C1 and C11 capacitors with a minimum value of 1 μF. The resistors and capacitors used for the analog input filter (R1, R2, C4, C5, and C8) are placed next to the decoupling capacitors. Use 1206-size, SMD-type, ceramic decoupling capacitors and route the traces to the AINx pins underneath. Connect the supply voltage sources in a way that allows the supply current to flow through the pads of the decoupling capacitors before powering the device.

Consider use of RC filters on the digital clock and data lines to reduce reflections and slew rate that cause radiated emissions. The AMC1336 evaluation module offers placeholders for RC filters (termed R8 and C13 in Figure 54) for the CLKIN line, and R7 and C12 for the DOUT line.

10.2 Layout Example

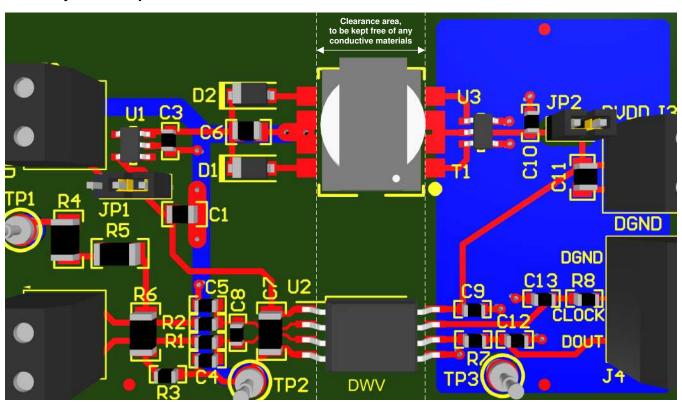


Figure 54. Recommended Layout of the AMC1336

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11 Device and Documentation Support

11.1 Device Support

11.1.1 Device Nomenclature

11.1.1.1 Isolation Glossary

See the Isolation Glossary

11.2 Documentation Support

11.2.1 Related Documentation

For related documentation see the following:

- Texas Instruments, TMS320F28004x Piccolo™ Microcontrollers data sheet
- Texas Instruments, TMS320F2807x Piccolo™ Microcontrollers data sheet
- Texas Instruments, TMS320F2837xD Dual-Core Delfino™ Microcontrollers data sheet
- Texas Instruments, ISO72x Digital Isolator Magnetic-Field Immunity
- Texas Instruments, MSP430F677x Polyphase Metering SoCs data sheet
- Texas Instruments, AMC1210 Quad Digital Filter for 2nd-Order Delta-Sigma Modulator data sheet
- Texas Instruments, Combining the ADS1202 with an FPGA Digital Filter for Current Measurement in Motor Control Applications application report
- Texas Instruments, AMC1306x Small, High-Precision, Reinforced Isolated Delta-Sigma Modulators With High CMTI data sheet
- Texas Instruments, CDCLVC11xx 3.3-V and 2.5-V LVCMOS High-Performance Clock Buffer Family data sheet
- Texas Instruments, SN6501 ransformer Driver for Isolated Power Supplies data sheet
- Texas Instruments, AMC1303, AMC1306, and AMC1336 Evaluation Module user's guide

11.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

11.4 Community Resources

TI E2ETM support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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11.5 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

11.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

11.7 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.



12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
AMC1336DWV	Active	Production	SOIC (DWV) 8	64 TUBE	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	AMC1336
AMC1336DWV.A	Active	Production	SOIC (DWV) 8	64 TUBE	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	AMC1336
AMC1336DWV.B	Active	Production	SOIC (DWV) 8	64 TUBE	-	Call TI	Call TI	-40 to 125	
AMC1336DWVR	Active	Production	SOIC (DWV) 8	1000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	AMC1336
AMC1336DWVR.A	Active	Production	SOIC (DWV) 8	1000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	AMC1336
AMC1336DWVR.B	Active	Production	SOIC (DWV) 8	1000 LARGE T&R	-	Call TI	Call TI	-40 to 125	

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE OPTION ADDENDUM

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OTHER QUALIFIED VERSIONS OF AMC1336:

Automotive : AMC1336-Q1

NOTE: Qualified Version Definitions:

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
AMC1336DWVR	SOIC	DWV	8	1000	330.0	16.4	12.15	6.2	3.05	16.0	16.0	Q1

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*All dimensions are nominal

	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
I	AMC1336DWVR	SOIC	DWV	8	1000	353.0	353.0	32.0

PACKAGE MATERIALS INFORMATION

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TUBE



*All dimensions are nominal

Device	Package Name		Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
AMC1336DW	/	DWV	SOIC	8	64	505.46	13.94	4826	6.6
AMC1336DWV	A	DWV	SOIC	8	64	505.46	13.94	4826	6.6



SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.



SOIC



NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



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